

Notice of References Cited	Application/Control No. 10/600,631	Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner D. Margaret Seaman	Art Unit 1625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,633,262	05-1997	Hong et al.	514/300
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	O	EP 0 688 771 A1	12-1995	EP		
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	V	Hyun, CA 134:33080, 2000.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.